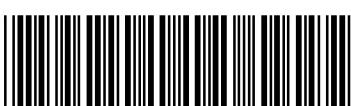


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10566344	LEE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Zachary Best	1795

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
429	231.95, 231.8, 218.1	6/2/10	zpb

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	6/2/10	zpb
Inventor Search	6/2/10	zpb
NPL Search	6/2/10	zpb
EAST	10/28/10	zpb

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
429	231.95, 231.8, 218.1	6/2/10	zpb

/Zachary Best/  
Examiner.Art Unit 1727